

Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/775,139	KRAMER ET AL.
	Examiner Devin Hanan	Art Unit 3745

ORIGINAL				CROSS REFERENCE(S)							
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)								
416	241R	415	12								
INTERNATIONAL CLASSIFICATION											
F	0	1	D	5/14							
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<i>Devin Hanan 9/19/2005</i> Devin Hanan 9/19/2005 (Assistant Examiner) (Date)				<i>Edward K. Look 9/19/05</i> EDWARD K. LOOK SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 3700 (Primary Examiner) (Date)				Total Claims Allowed: 6			
<i>K. Cooper 9/20/05</i> (KLegal Instruments Examiner) (Date)								O.G. Print Claim(s) 2	O.G. Print Fig 1		

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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4	5	35	65	95	125	155	185
5	6	36	66	96	126	156	186
6	7	37	67	97	127	157	187
8	38	68	98	128	129	158	188
9	39	69	99	130	131	159	189
10	40	70	100	132	133	160	190
11	41	71	101	134	135	161	191
12	42	72	102	136	137	162	192
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15	45	75	105	142	143	165	195
16	46	76	106	144	145	166	196
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19	49	79	109	150		169	199
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26	56	86	116			176	206
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